

Notice of References Cited	Application/Control No. 10/624,212		Applicant(s)/Patent Under Reexamination DUNCAN ET AL.	
	Examiner John B. Strege		Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,177,556	01-1993	Rioux, Marc	356/73
*	B	US-5,708,498	01-1998	Rioux et al.	356/73
*	C	US-7,010,176	03-2006	Kusunoki, Naoki	382/299
*	D	US-7,104,455	09-2006	Tsikos et al.	235/462.32
*	E	US-4,627,734	12-1986	Rioux, Marc	356/607
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hancock et al., Active Laser Radar for High-Performance Measurements, 1998, IEEE, 1465-1470
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.